## Notice of References Cited Application/Control No. 10/578,148 Examiner MICHAEL N. OPSASNICK Applicant(s)/Patent Under Reexamination YEUNG ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0111266	06-2004	Coorman et al.	704/260
*	В	US-5,890,117	03-1999	Silverman, Kim Ernest Alexander	704/260
*	С	US-5,384,893	01-1995	Hutchins, Sandra E.	704/267
*	D	US-5,652,828	07-1997	Silverman, Kim Ernest Alexander	704/260
*	Е	US-5,751,906	05-1998	Silverman, Kim Ernest Alexander	704/260
*	F	US-6,192,337	02-2001	Ittycheriah et al.	704/231
*	G	US-6,411,932	06-2002	Molnar et al.	704/260
*	Ι	US-6,839,669	01-2005	Gould et al.	704/246
*	I	US-6,122,614	09-2000	Kahn et al.	704/235
*	J	US-7,194,471	03-2007	Nagatsuka et al.	707/100
*	K	US-5,740,318	04-1998	Naito et al.	704/253
*	L	US-6,260,011	07-2001	Heckerman et al.	704/235
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.